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### Understanding [Embedded - FPGAs \(Field Programmable Gate Array\)](#)

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

### Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

#### Details

Product Status	Active
Number of LABs/CLBs	152700
Number of Logic Elements/Cells	1954560
Total RAM Bits	47628288
Number of I/O	1200
Number of Gates	-
Voltage - Supply	0.97V ~ 1.03V
Mounting Type	Surface Mount
Operating Temperature	0°C ~ 85°C (TJ)
Package / Case	1924-BBGA, FCBGA
Supplier Device Package	1925-FCBGA (45x45)
Purchase URL	<a href="https://www.e-xfl.com/product-detail/xilinx/xc7v2000t-1flg1925c">https://www.e-xfl.com/product-detail/xilinx/xc7v2000t-1flg1925c</a>



Table 5:  $V_{IN}$  Maximum Allowed AC Voltage Overshoot and Undershoot for 1.8V HP I/O Banks<sup>(1)(2)</sup>

AC Voltage Overshoot	% of UI @-40°C to 100°C	AC Voltage Undershoot	% of UI @-40°C to 100°C
$V_{CCO} + 0.55$	100	-0.55	100
$V_{CCO} + 0.60$	50.0	-0.60	50.0
$V_{CCO} + 0.65$	50.0	-0.65	50.0
$V_{CCO} + 0.70$	47.0	-0.70	50.0
$V_{CCO} + 0.75$	21.2	-0.75	50.0
$V_{CCO} + 0.80$	9.71	-0.80	50.0
$V_{CCO} + 0.85$	4.51	-0.85	28.4
$V_{CCO} + 0.90$	2.12	-0.90	12.7
$V_{CCO} + 0.95$	1.01	-0.95	5.79

**Notes:**

1. A total of 200 mA per bank should not be exceeded.
2. For UI smaller than 20  $\mu$ s.

Table 6: Typical Quiescent Supply Current

Symbol	Description	Device	Speed Grade			Units
			-3	-2/-2L/-2G	-1	
I <sub>CCINTQ</sub>	Quiescent $V_{CCINT}$ supply current	XC7V585T	1483	1483	1483	mA
		XC7V2000T	N/A	3756	3756	mA
		XC7VX330T	1012	1012	1012	mA
		XC7VX415T	1324	1324	1324	mA
		XC7VX485T	1578	1578	1578	mA
		XC7VX550T	2214	2214	2214	mA
		XC7VX690T	2214	2214	2214	mA
		XC7VX980T	N/A	2580	2580	mA
		XC7VX1140T	N/A	3448	3448	mA
I <sub>CCOQ</sub>	Quiescent $V_{CCO}$ supply current	XC7V585T	1	1	1	mA
		XC7V2000T	N/A	1	1	mA
		XC7VX330T	1	1	1	mA
		XC7VX415T	1	1	1	mA
		XC7VX485T	1	1	1	mA
		XC7VX550T	1	1	1	mA
		XC7VX690T	1	1	1	mA
		XC7VX980T	N/A	1	1	mA
		XC7VX1140T	N/A	1	1	mA

## Power-On/Off Power Supply Sequencing

The recommended power-on sequence is  $V_{CCINT}$ ,  $V_{CCBRAM}$ ,  $V_{CCAUX}$ ,  $V_{CCAUX\_IO}$ , and  $V_{CCO}$  to achieve minimum current draw and ensure that the I/Os are 3-stated at power-on. The recommended power-off sequence is the reverse of the power-on sequence. If  $V_{CCINT}$  and  $V_{CCBRAM}$  have the same recommended voltage levels then both can be powered by the same supply and ramped simultaneously. If  $V_{CCAUX}$ ,  $V_{CCAUX\_IO}$ , and  $V_{CCO}$  have the same recommended voltage levels then they can be powered by the same supply and ramped simultaneously.

For  $V_{CCO}$  voltages of 3.3V in HR I/O banks and configuration bank 0:

- The voltage difference between  $V_{CCO}$  and  $V_{CCAUX}$  must not exceed 2.625V for longer than  $T_{VCCO2VCCAUX}$  for each power-on/off cycle to maintain device reliability levels.
- The  $T_{VCCO2VCCAUX}$  time can be allocated in any percentage between the power-on and power-off ramps.

The recommended power-on sequence to achieve minimum current draw for the GTX/GTH transceivers is  $V_{CCINT}$ ,  $V_{MGTAVCC}$ ,  $V_{MGTAVTT}$  OR  $V_{MGTAVCC}$ ,  $V_{CCINT}$ ,  $V_{MGTAVTT}$ . There is no recommended sequencing for  $V_{MGTAVCAUX}$ . Both  $V_{MGTAVCC}$  and  $V_{CCINT}$  can be ramped simultaneously. The recommended power-off sequence is the reverse of the power-on sequence to achieve minimum current draw.

If these recommended sequences are not met, current drawn from  $V_{MGTAVTT}$  can be higher than specifications during power-up and power-down.

- When  $V_{MGTAVTT}$  is powered before  $V_{MGTAVCC}$  and  $V_{MGTAVTT} - V_{MGTAVCC} > 150$  mV and  $V_{MGTAVCC} < 0.7$ V, the  $V_{MGTAVTT}$  current draw can increase by 460 mA per transceiver during  $V_{MGTAVCC}$  ramp up. The duration of the current draw can be up to  $0.3 \times T_{MGTAVCC}$  (ramp time from GND to 90% of  $V_{MGTAVCC}$ ). The reverse is true for power-down.
- When  $V_{MGTAVTT}$  is powered before  $V_{CCINT}$  and  $V_{MGTAVTT} - V_{CCINT} > 150$  mV and  $V_{CCINT} < 0.7$ V, the  $V_{MGTAVTT}$  current draw can increase by 50 mA per transceiver during  $V_{CCINT}$  ramp up. The duration of the current draw can be up to  $0.3 \times T_{VCCINT}$  (ramp time from GND to 90% of  $V_{CCINT}$ ). The reverse is true for power-down.

## LVDS DC Specifications (LVDS\_25)

The LVDS standard is available in the HR I/O banks.

**Table 12: LVDS\_25 DC Specifications<sup>(1)</sup>**

Symbol	DC Parameter	Conditions	Min	Typ	Max	Units
$V_{CCO}$	Supply voltage		2.375	2.500	2.625	V
$V_{OH}$	Output High voltage for Q and $\bar{Q}$	$R_T = 100 \Omega$ across Q and $\bar{Q}$ signals	–	–	1.675	V
$V_{OL}$	Output Low voltage for Q and $\bar{Q}$	$R_T = 100 \Omega$ across Q and $\bar{Q}$ signals	0.700	–	–	V
$V_{ODIFF}$	Differential output voltage ( $Q - \bar{Q}$ ), Q = High ( $Q - Q$ ), $\bar{Q}$ = High	$R_T = 100 \Omega$ across Q and $\bar{Q}$ signals	247	350	600	mV
$V_{OCM}$	Output common-mode voltage	$R_T = 100 \Omega$ across Q and $\bar{Q}$ signals	1.000	1.250	1.425	V
$V_{IDIFF}$	Differential input voltage ( $Q - \bar{Q}$ ), Q = High ( $\bar{Q} - Q$ ), $\bar{Q}$ = High		100	350	600	mV
$V_{ICM}$	Input common-mode voltage		0.300	1.200	1.425	V

**Notes:**

1. Differential inputs for LVDS\_25 can be placed in banks with  $V_{CCO}$  levels that are different from the required level for outputs. Consult the 7 Series FPGAs SelectIO Resources User Guide ([UG471](#)) for more information.

## LVDS DC Specifications (LVDS)

The LVDS standard is available in the HP I/O banks.

**Table 13: LVDS DC Specifications**

Symbol	DC Parameter	Conditions	Min	Typ	Max	Units
$V_{CCO}$	Supply voltage		1.710	1.800	1.890	V
$V_{OH}$	Output High voltage for Q and $\bar{Q}$	$R_T = 100 \Omega$ across Q and $\bar{Q}$ signals	–	–	1.675	V
$V_{OL}$	Output Low voltage for Q and $\bar{Q}$	$R_T = 100 \Omega$ across Q and $\bar{Q}$ signals	0.825	–	–	V
$V_{ODIFF}$	Differential output voltage ( $Q - \bar{Q}$ ), Q = High ( $Q - Q$ ), $\bar{Q}$ = High	$R_T = 100 \Omega$ across Q and $\bar{Q}$ signals	247	350	600	mV
$V_{OCM}$	Output common-mode voltage	$R_T = 100 \Omega$ across Q and $\bar{Q}$ signals	1.000	1.250	1.425	V
$V_{IDIFF}$	Differential input voltage ( $Q - \bar{Q}$ ), Q = High ( $\bar{Q} - Q$ ), $\bar{Q}$ = High	Common-mode input voltage = 1.25V	100	350	600	mV
$V_{ICM}$	Input common-mode voltage	Differential input voltage = ±350 mV	0.300	1.200	1.425	V

**Notes:**

1. Differential inputs for LVDS can be placed in banks with  $V_{CCO}$  levels that are different from the required level for outputs. Consult the 7 Series FPGAs SelectIO Resources User Guide ([UG471](#)) for more information.

## AC Switching Characteristics

All values represented in this data sheet are based on the speed specifications in the ISE® Design Suite 14.5 and Vivado® Design Suite 2013.1 as outlined in [Table 14](#).

**Table 14: Virtex-7 T and XT FPGA Speed Specification Version By Device/Speed Grade**

Version In:		Typical V <sub>CCINT</sub>	Device
ISE 14.5	Vivado 2013.1	( <a href="#">Table 2</a> )	
1.09	1.09	1.0V	XC7V585T, XC7VX485T
N/A	1.08	1.0V	XC7V2000T
1.08	1.08	1.0V	XC7VX330T, XC7VX415T, XC7VX550T, XC7VX690T, XC7VX980T
N/A	1.08	1.0V	XC7VX1140T

Switching characteristics are specified on a per-speed-grade basis and can be designated as Advance, Preliminary, or Production. Each designation is defined as follows:

### **Advance Product Specification**

These specifications are based on simulations only and are typically available soon after device design specifications are frozen. Although speed grades with this designation are considered relatively stable and conservative, some under-reporting might still occur.

### **Preliminary Product Specification**

These specifications are based on complete ES (engineering sample) silicon characterization. Devices and speed grades with this designation are intended to give a better indication of the expected performance of production silicon. The probability of under-reporting delays is greatly reduced as compared to Advance data.

### **Production Product Specification**

These specifications are released once enough production silicon of a particular device family member has been characterized to provide full correlation between specifications and devices over numerous production lots. There is no under-reporting of delays, and customers receive formal notification of any subsequent changes. Typically, the slowest speed grades transition to Production before faster speed grades.

## Testing of AC Switching Characteristics

Internal timing parameters are derived from measuring internal test patterns. All AC switching characteristics are representative of worst-case supply voltage and junction temperature conditions.

For more specific, more precise, and worst-case guaranteed data, use the values reported by the static timing analyzer and back-annotate to the simulation net list. Unless otherwise noted, values apply to all Virtex-7 T and XT FPGAs.

## Speed Grade Designations

Since individual family members are produced at different times, the migration from one category to another depends completely on the status of the fabrication process for each device. [Table 15](#) correlates the current status of each Virtex-7 T and XT device on a per speed grade basis.

[Table 15: Virtex-7 T and XT Device Speed Grade Designations](#)

Device	Speed Grade Designations		
	Advance	Preliminary	Production
XC7V585T			-3, -2, -2L, -1
XC7V2000T	-2L, -2G		-2, -1
XC7VX330T			-3, -2, -2L, -1
XC7VX415T			-3, -2, -2L, -1
XC7VX485T			-3, -2, -2L, -1
XC7VX550T			-3, -2, -2L, -1
XC7VX690T			-3, -2, -2L, -1
XC7VX980T	-2, -2L, -1		
XC7VX1140T	-2, -2L, -2G, -1		

## Production Silicon and Software Status

In some cases, a particular family member (and speed grade) is released to production before a speed specification is released with the correct label (Advance, Preliminary, Production). Any labeling discrepancies are corrected in subsequent speed specification releases.

[Table 16](#) lists the production released Virtex-7 T and XT device, speed grade, and the minimum corresponding supported speed specification version and software revisions. The software and speed specifications listed are the minimum releases required for production. All subsequent releases of software and speed specifications are valid.

[Table 16: Virtex-7 T and XT Device Production Software and Speed Specification Release](#)

Device	Speed Grade Designations				
	-3	-2G	-2	-2L	-1
XC7V585T	Vivado 2012.4 v1.08 or ISE 14.2 v1.06	N/A	Vivado 2012.4 v1.08 or ISE 14.2 v1.06		
XC7V2000T	N/A		Vivado 2012.4 v1.07		Vivado 2012.4 v1.07
XC7VX330T	Vivado 2013.1 v1.08 or ISE 14.5 v1.08	N/A	Vivado 2013.1 v1.08 or ISE 14.5 v1.08		
XC7VX415T		N/A			
XC7VX485T	Vivado 2012.4 v1.08 or ISE 14.2 v1.06	N/A	Vivado 2012.4 v1.08 or ISE 14.2 v1.06		
XC7VX550T	Vivado 2013.1 v1.08 or ISE 14.5 v1.08	N/A	Vivado 2013.1 v1.08 or ISE 14.5 v1.08		
XC7VX690T	Vivado 2013.1 v1.08 or ISE 14.5 v1.08	N/A	Vivado 2013.1 v1.08 or ISE 14.5 v1.08		
XC7VX980T	N/A	N/A			
XC7VX1140T	N/A				

### Notes:

- Blank entries indicate a device and/or speed grade in advance or preliminary status.

**Table 18: Maximum Physical Interface (PHY) Rate for Memory Interfaces IP available with the Memory Interface Generator<sup>(1)(2)</sup>**

Memory Standard	I/O Bank Type	V <sub>CCAUX_IO</sub>	Speed Grade			Units
			-3	-2/-2L/-2G	-1	
<b>4:1 Memory Controllers</b>						
DDR3	HP	2.0V	1866	1866	1600	Mb/s
	HP	1.8V	1600	1333	1066	Mb/s
	HR	N/A	1066	1066	800	Mb/s
DDR3L	HP	2.0V	1600	1600	1333	Mb/s
	HP	1.8V	1333	1066	800	Mb/s
	HR	N/A	800	800	667	Mb/s
DDR2	HP	2.0V	800	800	800	Mb/s
	HP	1.8V	800	800	800	Mb/s
	HR	N/A	800	800	800	Mb/s
RLDRAM III	HP	2.0V	800	667	667	MHz
	HP	1.8V	550	500	450	MHz
	HR	N/A			N/A	
<b>2:1 Memory Controllers</b>						
DDR3	HP	2.0V	1066	1066	800	Mb/s
	HP	1.8V	1066	1066	800	Mb/s
	HR	N/A	1066	1066	800	Mb/s
DDR3L	HP	2.0V	1066	1066	800	Mb/s
	HP	1.8V	1066	1066	800	Mb/s
	HR	N/A	800	800	667	Mb/s
DDR2	HP	2.0V	800	800	800	Mb/s
	HP	1.8V				
	HR	N/A				
QDR II+ <sup>(3)</sup>	HP	2.0V	550	500	450	MHz
	HP	1.8V				
	HR	N/A				
RLDRAM II	HP	2.0V	533	500	450	MHz
	HP	1.8V				
	HR	N/A				
LPDDR2	HP	2.0V	667	667	667	Mb/s
	HP	1.8V	667	667	667	Mb/s
	HR	N/A	667	667	667	Mb/s

**Notes:**

1. V<sub>REF</sub> tracking is required. For more information, see the 7 Series FPGAs Memory Interface Solutions User Guide ([UG586](#)).
2. When using the internal V<sub>REF</sub> the maximum data rate is 800 Mb/s (400 MHz).
3. The maximum QDRII+ performance specifications are for burst-length 4 (BL = 4) implementations. Burst length 2 (BL = 2) implementations are limited to 333 MHz for all speed grades and I/O bank types.







## Input/Output Logic Switching Characteristics

Table 22: ILOGIC Switching Characteristics

Symbol	Description	Speed Grade			Units
		-3	-2/-2L/-2G	-1	
<b>Setup/Hold</b>					
T <sub>ICE1CK/T<sub>ICKCE1</sub></sub>	CE1 pin setup/hold with respect to CLK	0.42/0.00	0.48/0.00	0.67/0.00	ns
T <sub>ISRCK/T<sub>ICKSR</sub></sub>	SR pin setup/hold with respect to CLK	0.53/0.01	0.61/0.01	0.99/0.01	ns
T <sub>IDOCKE2/T<sub>IOCKDE2</sub></sub>	D pin setup/hold with respect to CLK without delay (HP I/O banks only)	0.01/0.27	0.01/0.29	0.01/0.34	ns
T <sub>IDOCKDE2/T<sub>IOCKDDE2</sub></sub>	DDLY pin setup/hold with respect to CLK (using IDELAY) (HP I/O banks only)	0.01/0.27	0.02/0.29	0.02/0.34	ns
T <sub>IDOCKE3/T<sub>IOCKDE3</sub></sub>	D pin setup/hold with respect to CLK without delay (HR I/O banks only)	0.01/0.27	0.01/0.29	0.01/0.34	ns
T <sub>IDOCKDE3/T<sub>IOCKDDE3</sub></sub>	DDLY pin setup/hold with respect to CLK (using IDELAY) (HR I/O banks only)	0.01/0.27	0.02/0.29	0.02/0.34	ns
<b>Combinatorial</b>					
T <sub>IDIE2</sub>	D pin to O pin propagation delay, no delay (HP I/O banks only)	0.09	0.10	0.12	ns
T <sub>IDIDE2</sub>	DDLY pin to O pin propagation delay (using IDELAY) (HP I/O banks only)	0.10	0.11	0.13	ns
T <sub>IDIE3</sub>	D pin to O pin propagation delay, no delay (HR I/O banks only)	0.09	0.10	0.12	ns
T <sub>IDIDE3</sub>	DDLY pin to O pin propagation delay (using IDELAY) (HR I/O banks only)	0.10	0.11	0.13	ns
<b>Sequential Delays</b>					
T <sub>IDLOE2</sub>	D pin to Q1 pin using flip-flop as a latch without delay (HP I/O banks only)	0.36	0.39	0.45	ns
T <sub>IDLODE2</sub>	DDLY pin to Q1 pin using flip-flop as a latch (using IDELAY) (HP I/O banks only)	0.36	0.39	0.45	ns
T <sub>IDLOE3</sub>	D pin to Q1 pin using flip-flop as a latch without delay (HR I/O banks only)	0.36	0.39	0.45	ns
T <sub>IDLODE3</sub>	DDLY pin to Q1 pin using flip-flop as a latch (using IDELAY) (HR I/O banks only)	0.36	0.39	0.45	ns
T <sub>ICKQ</sub>	CLK to Q outputs	0.47	0.50	0.58	ns
T <sub>RQ_ILOGICE2</sub>	SR pin to OQ/TQ out (HP I/O banks only)	0.84	0.94	1.16	ns
T <sub>GSRQ_ILOGICE2</sub>	Global set/reset to Q outputs (HP I/O banks only)	7.60	7.60	10.51	ns
T <sub>RQ_ILOGICE3</sub>	SR pin to OQ/TQ out (HR I/O banks only)	0.84	0.94	1.16	ns
T <sub>GSRQ_ILOGICE3</sub>	Global set/reset to Q outputs (HR I/O banks only)	7.60	7.60	10.51	ns
<b>Set/Reset</b>					
T <sub>RPW_ILOGICE2</sub>	Minimum pulse width, SR inputs (HP I/O banks only)	0.54	0.63	0.63	ns, Min
T <sub>RPW_ILOGICE3</sub>	Minimum pulse width, SR inputs (HR I/O banks only)	0.54	0.63	0.63	ns, Min

Table 23: OLOGIC Switching Characteristics

Symbol	Description	Speed Grade			Units
		-3	-2/-2L/-2G	-1	
<b>Setup/Hold</b>					
TODCK/TOCKD	D1/D2 pins setup/hold with respect to CLK	0.45/-0.13	0.50/-0.13	0.58/-0.13	ns
TOOCECK/TOCKOCE	OCE pin setup/hold with respect to CLK	0.28/0.03	0.29/0.03	0.45/0.03	ns
TOSRCK/TOCKSR	SR pin setup/hold with respect to CLK	0.32/0.18	0.38/0.18	0.70/0.18	ns
TOTCK/TOCKT	T1/T2 pins setup/hold with respect to CLK	0.49/-0.16	0.56/-0.16	0.68/-0.16	ns
TOTCECK/TOCKTCE	TCE pin setup/hold with respect to CLK	0.28/0.01	0.30/0.01	0.45/0.01	ns
<b>Combinatorial</b>					
TODQ	D1 to OQ out or T1 to TQ out	0.73	0.81	0.97	ns
<b>Sequential Delays</b>					
TOCKQ	CLK to OQ/TQ out	0.41	0.43	0.49	ns
TRQ_OLOGICE2	SR pin to OQ/TQ out (HP I/O banks only)	0.63	0.70	0.83	ns
TGSRQ_OLOGICE2	Global set/reset to Q outputs (HP I/O banks only)	7.60	7.60	10.51	ns
TRQ_OLOGICE3	SR pin to OQ/TQ out (HR I/O banks only)	0.63	0.70	0.83	ns
TGSRQ_OLOGICE3	Global set/reset to Q outputs (HR I/O banks only)	7.60	7.60	10.51	ns
<b>Set/Reset</b>					
TRPW_OLOGICE2	Minimum pulse width, SR inputs (HP I/O banks only)	0.54	0.54	0.63	ns, Min
TRPW_OLOGICE3	Minimum pulse width, SR inputs (HR I/O banks only)	0.54	0.54	0.63	ns, Min

Table 31: Block RAM and FIFO Switching Characteristics (Cont'd)

Symbol	Description	Speed Grade			Units
		-3	-2/-2L/-2G	-1	
<b>Maximum Frequency</b>					
F <sub>MAX_BRAM_WF_NC</sub>	Block RAM (Write first and No change modes) When not in SDP RF mode	601.32	543.77	458.09	MHz
F <sub>MAX_BRAM_RF_PERFORMANCE</sub>	Block RAM (Read first, Performance mode) When in SDP RF mode but no address overlap between port A and port B	601.32	543.77	458.09	MHz
F <sub>MAX_BRAM_RF_DELAYED_WRITE</sub>	Block RAM (Read first, Delayed_write mode) When in SDP RF mode and there is possibility of overlap between port A and port B addresses	528.26	477.33	400.80	MHz
F <sub>MAX_CAS_WF_NC</sub>	Block RAM Cascade (Write first, No change mode) When cascade but not in RF mode	551.27	493.83	408.00	MHz
F <sub>MAX_CAS_RF_PERFORMANCE</sub>	Block RAM Cascade (Read first, Performance mode) When in cascade with RF mode and no possibility of address overlap/one port is disabled	551.27	493.83	408.00	MHz
F <sub>MAX_CAS_RF_DELAYED_WRITE</sub>	When in cascade RF mode and there is a possibility of address overlap between port A and port B	478.24	427.35	350.88	MHz
F <sub>MAX_FIFO</sub>	FIFO in all modes without ECC	601.32	543.77	458.09	MHz
F <sub>MAX_ECC</sub>	Block RAM and FIFO in ECC configuration	484.26	430.85	351.12	MHz

**Notes:**

1. The timing report shows all of these parameters as T<sub>RCKO\_DO</sub>.
2. T<sub>RCKO\_DOR</sub> includes T<sub>RCKO\_DOW</sub>, T<sub>RCKO\_DOPR</sub>, and T<sub>RCKO\_DOPW</sub> as well as the B port equivalent timing parameters.
3. These parameters also apply to synchronous FIFO with DO\_REG = 0.
4. T<sub>RCKO\_DO</sub> includes T<sub>RCKO\_DOP</sub> as well as the B port equivalent timing parameters.
5. These parameters also apply to multirate (asynchronous) and synchronous FIFO with DO\_REG = 1.
6. T<sub>RCKO\_FLAGS</sub> includes the following parameters: T<sub>RCKO\_AEMPTY</sub>, T<sub>RCKO\_AFULL</sub>, T<sub>RCKO\_EMPTY</sub>, T<sub>RCKO\_FULL</sub>, T<sub>RCKO\_RDERR</sub>, T<sub>RCKO\_WRERR</sub>.
7. T<sub>RCKO\_POINTERS</sub> includes both T<sub>RCKO\_RDCOUNT</sub> and T<sub>RCKO\_WRCOUNT</sub>.
8. The ADDR setup and hold must be met when EN is asserted (even when WE is deasserted). Otherwise, block RAM data corruption is possible.
9. These parameters include both A and B inputs as well as the parity inputs of A and B.
10. T<sub>RCKO\_FLAGS</sub> includes the following flags: AEMPTY, AFULL, EMPTY, FULL, RDERR, WRERR, RDCOUNT, and WRCOUNT.
11. RDEN and WREN must be held Low prior to and during reset. The FIFO reset must be asserted for at least five positive clock edges of the slowest clock (WRCLK or RDCLK).







Table 78: CEI-6G and CEI-11G Protocol Characteristics (GTH Transceivers)

Description	Line Rate (Mb/s)	Interface	Min	Max	Units
<b>CEI-6G Transmitter Jitter Generation</b>					
Total transmitter jitter <sup>(1)</sup>	4976–6375	CEI-6G-SR	–	0.3	UI
		CEI-6G-LR	–	0.3	UI
<b>CEI-6G Receiver High Frequency Jitter Tolerance</b>					
Total receiver jitter tolerance <sup>(1)</sup>	4976–6375	CEI-6G-SR	0.6	–	UI
		CEI-6G-LR	0.95	–	UI
<b>CEI-11G Transmitter Jitter Generation</b>					
Total transmitter jitter <sup>(2)</sup>	9950–11100	CEI-11G-SR	–	0.3	UI
		CEI-11G-LR/MR	–	0.3	UI
<b>CEI-11G Receiver High Frequency Jitter Tolerance</b>					
Total receiver jitter tolerance <sup>(2)</sup>	9950–11100	CEI-11G-SR	0.65	–	UI
		CEI-11G-MR	0.65	–	UI
		CEI-11G-LR	0.825	–	UI

**Notes:**

1. Tested at most commonly used line rate of 6250 Mb/s using 390.625 MHz reference clock.
2. Tested at line rate of 9950 Mb/s using 155.46875 MHz reference clock and 11100 Mb/s using 173.4375 MHz reference clock.

Table 79: SFP+ Protocol Characteristics (GTH Transceivers)

Description	Line Rate (Mb/s)	Min	Max	Units
<b>SFP+ Transmitter Jitter Generation</b>				
Total transmitter jitter	9830.40 <sup>(1)</sup>	–	0.28	UI
	9953.00			
	10312.50			
	10518.75			
	11100.00			
<b>SFP+ Receiver Frequency Jitter Tolerance</b>				
Total receiver jitter tolerance	9830.40 <sup>(1)</sup>	0.7	–	UI
	9953.00			
	10312.50			
	10518.75			
	11100.00			

**Notes:**

1. Line rated used for CPRI over SFP+ applications.

Table 80: CPRI Protocol Characteristics (GTH Transceivers)

Description	Line Rate (Mb/s)	Min	Max	Units
<b>CPRI Transmitter Jitter Generation</b>				
Total transmitter jitter	614.4	–	0.35	UI
	1228.8	–	0.35	UI
	2457.6	–	0.35	UI
	3072.0	–	0.35	UI
	4915.2	–	0.3	UI
	6144.0	–	0.3	UI
	9830.4	–	Note 1	UI
<b>CPRI Receiver Frequency Jitter Tolerance</b>				
Total receiver jitter tolerance	614.4	0.65	–	UI
	1228.8	0.65	–	UI
	2457.6	0.65	–	UI
	3072.0	0.65	–	UI
	4915.2	0.95	–	UI
	6144.0	0.95	–	UI
	9830.4	Note 1	–	UI

**Notes:**

- Tested per SFP+ specification, see [Table 79](#).

**Integrated Interface Block for PCI Express Designs Switching Characteristics**

More information and documentation on solutions for PCI Express designs can be found at:

<http://www.xilinx.com/technology/protocols/pciexpress.htm>

Table 81: Maximum Performance for PCI Express Designs

Symbol	Description	Speed Grade			Units
		-3	-2/-2L/-2G	-1	
FPIPECLK	Pipe clock maximum frequency	250.00	250.00	250.00	MHz
FUSERCLK	User clock maximum frequency	500.00	500.00	250.00	MHz
FUSERCLK2	User clock 2 maximum frequency	250.00	250.00	250.00	MHz
FRPCLK	DRP clock maximum frequency	250.00	250.00	250.00	MHz



Date	Version	Description
08/03/2012	1.5	<p>Updated the descriptions, changed <math>V_{IN}</math> and <a href="#">Note 2</a> and added <a href="#">Note 4</a> in <a href="#">Table 1</a>. In <a href="#">Table 2</a>, changed descriptions and notes, removed Note 7, changed GTX transceiver parameters and values and added <a href="#">Note 12</a> and <a href="#">Note 13</a>. Updated parameters in <a href="#">Table 3</a>. Added <a href="#">Table 4</a> and <a href="#">Table 5</a>. Updated the values for in <a href="#">Table 7</a>. Updated LVCMS12 and the SSTLs in <a href="#">Table 9</a>. Updated many of the specifications in <a href="#">Table 10</a> and <a href="#">Table 11</a>.</p> <p>Updated the <a href="#">AC Switching Characteristics</a> section, based upon <a href="#">Table 14</a>, for the ISE 14.2 speed specifications throughout the document with appropriate changes to <a href="#">Table 15</a> and <a href="#">Table 16</a> including production release of the XC7VX485T in the -2 and -1 speed designations.</p> <p>Added notes and specifications to <a href="#">Table 18</a>. Updated the <a href="#">IOB Pad Input/Output/3-State</a> discussion and changed <a href="#">Table 21</a> by adding <math>T_{IOIBUFDISABLE}</math>.</p> <p>Removed many of the combinatorial delay specifications and <math>T_{CINCK}/T_{CKCIN}</math> from <a href="#">Table 28</a>.</p> <p>Rearranged <a href="#">Table 51</a> including moving some parameters to <a href="#">Table 1</a>. Added <a href="#">Table 56</a>. Updated <a href="#">Table 57</a>. In <a href="#">Table 59</a>, updated SJ Jitter Tolerance with Stressed Eye section, <a href="#">page 48</a> and <a href="#">Note 8</a>. Added <a href="#">Note 1</a>, <a href="#">Note 2</a>, and <a href="#">Note 3</a> to <a href="#">Table 62</a>. Added <a href="#">Note 1</a> and <a href="#">Note 2</a> to <a href="#">Table 63</a>, and line rate ranges. Updated <a href="#">Table 64</a> including adding <a href="#">Note 1</a>. Updated <a href="#">Table 65</a> including adding <a href="#">Note 1</a>. In <a href="#">Table 82</a> updated <a href="#">Note 1</a> and added <a href="#">Note 4</a>. In <a href="#">Table 83</a>, updated <math>T_{POR}</math> and <math>F_{EMCCK}</math>.</p>
09/20/2012	1.6	Removed the XC7V1500T device from data sheet. In <a href="#">Table 2</a> , revised $V_{CCINT}$ and $V_{CCBRAM}$ and added <a href="#">Note 3</a> . Updated some of the values in <a href="#">Table 7</a> . Revised <a href="#">Table 15</a> and <a href="#">Table 16</a> to include production release of the XC7V585T in the -2 and -1 speed designations. Added values for the XC7V585T in <a href="#">Table 50</a> . Updated <a href="#">Note 2</a> in <a href="#">Table 58</a> .
09/26/2012	1.7	Revised <a href="#">Table 15</a> and <a href="#">Table 16</a> to include production release of the XC7VX485T in the -3 speed designation.
10/19/2012	1.8	Revised <a href="#">Table 15</a> and <a href="#">Table 16</a> to include production release of the XC7VX485T in the -2L (1.0V) speed designation. Removed -2L (0.9V) speed specifications from data sheet, this change includes edits to $V_{CCINT}$ and $V_{CCBRAM}$ in <a href="#">Table 2</a> , editing <a href="#">Note 1</a> and removing Note 2 in <a href="#">Table 53</a> . Also in <a href="#">Table 53</a> , updated the $F_{GTXMAX}$ , $F_{GTXQRANGE1}$ , and $F_{GQPLL RANGE1}$ specification for -1 speed grade from 6.6 Gb/s to 8.0 Gb/s. Edited <a href="#">Note 4</a> in <a href="#">Table 57</a> and <a href="#">Note 3</a> in <a href="#">Table 72</a> .
12/12/2012	1.9	Updated the <a href="#">AC Switching Characteristics</a> section, based upon <a href="#">Table 14</a> , for the ISE 14.3 speed specifications throughout the document. Revised <a href="#">Table 15</a> and <a href="#">Table 16</a> to include production release of the XC7V585T in the -3 and -2L(1.0V) speed designations. Updated the notes in <a href="#">Table 50</a> . Updated <a href="#">GTH Transceiver Specifications</a> including removal of GTH Transceiver DC Characteristics section (use the XPE (download at <a href="http://www.xilinx.com/power">http://www.xilinx.com/power</a> )). Updated <a href="#">Table 68</a> and added <a href="#">Table 71</a> , <a href="#">Table 73</a> , and <a href="#">Table 74</a> . Removed Note 4 from <a href="#">Table 82</a> .
12/24/2012	1.10	Updated the <a href="#">AC Switching Characteristics</a> section, based upon <a href="#">Table 14</a> , for the ISE 14.4 and Vivado 2012.4 speed specifications throughout the document. Revised the XC7V2000T in the -1 and -2 speed designations <a href="#">Table 15</a> to preliminary. Added the <a href="#">GTH Transceiver Protocol Jitter Characteristics</a> section. Updated $T_{TCKTDO}$ and added <a href="#">Internal Configuration Access Port</a> section to <a href="#">Table 83</a> .
01/31/2013	1.11	Added <a href="#">Note 2</a> to <a href="#">Table 2</a> . Revised <a href="#">Table 15</a> and <a href="#">Table 16</a> to include production release of the XC7V2000T in the -1 and -2 speed specifications. Updated <a href="#">Note 1</a> in <a href="#">Table 35</a> . Updated the notes in <a href="#">Table 37</a> , <a href="#">Table 40</a> through <a href="#">Table 43</a> , <a href="#">Table 46</a> , and <a href="#">Table 47</a> . In <a href="#">Table 66</a> , updated $D_{VPPIN}$ . In <a href="#">Table 67</a> , updated $V_{IDIFF}$ . Removed $T_{LOCK}$ and $T_{PHASE}$ from <a href="#">Table 70</a> . Updated $T_{DLOCK}$ in <a href="#">Table 71</a> .
03/07/2013	1.12	Updated the <a href="#">AC Switching Characteristics</a> section, based upon <a href="#">Table 14</a> , for the ISE 14.5 and Vivado 2013.1 speed specifications throughout the document. Revised <a href="#">Table 15</a> and <a href="#">Table 16</a> to include production release of the XC7VX690T. Revised $D_{VPPOUT}$ in <a href="#">Table 66</a> . Updated values in <a href="#">Table 67</a> and <a href="#">Table 74</a> . Removed Note 1 from <a href="#">Table 68</a> . Updated $MMCM\_F_{PFDMAX}$ in <a href="#">Table 38</a> and $PLL\_F_{PFDMAX}$ in <a href="#">Table 39</a> . Added skew values to <a href="#">Table 50</a> .